

<b>Notice of References Cited</b>	Application/Control No. 10/784,173		Applicant(s)/Patent Under Reexamination YOON ET AL.	
	Examiner Daniel D. Abebe		Art Unit 2626	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,170,432	12-1992	Hackbarth et al.	704/254
*	C	US-5,995,931	11-1999	Bahl et al.	704/257
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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